Manipulation of C$_{60}$ islands on the rutile TiO$_2$ (110) surface using noncontact atomic force microscopy

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Regular, almost quadratic pits were created in an island of C$_{60}$ molecules on a rutile TiO$_2$ (110) surface using noncontact atomic force microscopy at room temperature. Upon gradually approaching the scanning tip toward the surface, the interaction between the tip and the C$_{60}$ island was increased until manipulation was achieved. Analyzing the manipulation process unambiguously revealed that the manipulation was performed in the repulsive regime. Retracting the tip allowed for reproducible imaging the C$_{60}$ island after the manipulation process. Moreover, whole islands could be reshaped or even removed when scanning with appropriate scanning parameters. © 2009 American Institute of Physics. [DOI: 10.1063/1.3184784]

Long-term objective of investigating molecules on surfaces is to verify the applicability of creating materials with improved properties and functions at the nanoscale. A very appealing motivation is to adopt molecules as building blocks for nanoelectronics, since miniaturization of electronics by conventional lithographic methods is approaching its technical limits. To achieve ordered structures, different strategies are open to explore. The surface may be templated for a steered assembly of the molecules and exploiting molecular self-assembly is considered as a very promising strategy. However, employing parallel and autonomous techniques such as self-assembly in combination with direct patterning methods such as manipulation might allow for creating an even broader variety of structures. The most direct fabrication method of nanostructures is tip-induced manipulation, since the tip is controllable at the subnanometer scale.

Atomic and molecular manipulation has been studied extensively on metal surfaces using scanning tunneling microscopy (STM) and a rather comprehensive understanding of the manipulation process has been achieved. Using noncontact atomic force microscopy (NC-AFM), however, controlled manipulation of single atoms and atom size defects has been achieved in very few cases only. Compared to manipulation using the STM, only limited understanding has been gained so far based on experimental data and theoretical calculations. Lateral manipulation can be triggered by lowering the energy barriers for hopping processes due to attractive interactions between tip and surface adatoms or due to repulsive interaction between the tip and surface adsorbates/atoms. Like in STM, pulling as well as pushing manipulation mechanisms were proposed. In contrast with previous manipulation experiments using NC-AFM, we demonstrate well-controlled manipulation of large molecules.

In this work, the system of C$_{60}$ molecules on the rutile TiO$_2$ (110) surface was investigated with NC-AFM at room temperature. The C$_{60}$ fullerene is a promising candidate for molecular electronics due to its intrinsic amplifier effect. Moreover, considerations have been made about an application of C$_{60}$ molecules as single-molecule transistors. The corrugation of the TiO$_2$ (110) surface appears to be applicable for templating the C$_{60}$ molecules in between the one-dimensional stretched troughs for an ordered assembly. We demonstrate the tip-induced modification of C$_{60}$ islands due to clear repulsive interactions between tip and molecules. Thereby, we created pits in well-ordered islands and moved domain boundaries on the islands. Additionally, altering and removal of complete C$_{60}$ island is demonstrated.

Measurements were performed in an ultrahigh vacuum system (Omicron VT-AFM 25) operated in frequency modulation NC-AFM (FM NC-AFM) mode. Tip and sample preparation as well as the thermal sublimation of C$_{60}$ molecules onto the surface has been described previously. All experiments were performed at room temperature. In the present experiments, the distance feedback was not switched off completely. The frequency shift setpoint serves as a measure for the tip-sample distance in our experiments. The images are displayed such that bright areas correspond to high attractive interaction while dark corresponds to less attractive or even repulsive interactions.

On the rutile TiO$_2$ (110) surface, C$_{60}$ molecules are known to arrange in a centered rectangular superstructure with an angle of $81^\circ \pm 2^\circ$ and with the C$_{60}$ molecules lying centered in the troughs between the substrate’s bridging oxygen rows. The fact that islands are observed at room temperature indicates that C$_{60}$ molecules are mobile at this temperature. Only rarely, individual molecules are observed on the terrace. Consequently, these molecules must be anchored to surface defects. As the density of the well-known hydroxyl defects is known to be much higher than the observed individual molecules, the C$_{60}$ molecules are not anchored to the hydroxy defects. Protruding molecular rows appear on the C$_{60}$ islands, which are ascribed to domain boundaries originating from stacking faults. In Fig. 1(a), a C$_{60}$ layer including such domain boundaries is displayed. When scanning on the C$_{60}$ islands, we created holes into these islands by scanning at increased frequency shift setpoints. An example is shown in Fig. 1. Image (a) was recorded at a frequency shift setpoint of $-10.4$ Hz. From this point, the frequency shift setpoint was increased stepwise in the following images, resulting in contrast inversion as discussed in Ref. 28. The corresponding images can be seen in Ref. 28. Very stable imaging was possible until a setpoint of $-25.1$ Hz was reached. At this setpoint, the tip interacts sufficiently with the
C$_{60}$ molecules to remove C$_{60}$ molecules from the island. In Fig. 2(a) the upper part of the image was scanned at a setpoint of $-25.1$ Hz, showing full contrast inversion (i.e., the C$_{60}$ molecules appear dark while the areas in between the molecules appear bright). Near the stacking fault (see area enclosed by the dotted lines), the manipulation occurred and is analyzed in the following. Every measured scanline in this manipulation area can be seen for both forward and backward scan on the left hand side in Fig. 2. Two line scans in the forward scan reveal significant positive frequency shifts, corresponding to a repulsive interaction between tip and molecules. This can be related to the observed manipulation process. In the lower part of the image, the frequency shift setpoint was lowered to $-19.1$ Hz, again resulting in stable imaging. The contrast is the same again as was seen at $-19.1$ Hz before the manipulation process.

The situation after the manipulation [Fig. 1(b)] was recorded at the same frequency shift setpoint as the first image. Comparing both images [Figs. 1(a) and 1(b)], an almost quadratic hole was created by removal of 12 C$_{60}$ molecules from the plain island and 5 molecules at the upper domain boundary. In addition, a reordering of the lower left domain boundary was induced. This boundary moved one repeat distance closer to the encircled vacancy in the molecular island (indicated by three/two white circles between the domain boundaries). As the domain boundaries originate from stacking faults, the observed reordering must be caused by a movement of the associated stacking fault during the manipulation process. The reordering of this domain boundary is linked to a rather large mass transport, as 1+2×$n$ molecules need to change position in order to shift the whole boundary, with $n$ being the number of C$_{60}$ molecules in length on the domain boundary. Additionally, one C$_{60}$ molecule needs to be removed, otherwise, the boundary cannot be moved.

In Fig. 3(a), a C$_{60}$ island of ~25 nm in length and ~14 nm in width is scanned. In Figs. 3(a)–3(l) this island shrinks in size when scanning at frequency shift setpoints between $-13.0$ and $-15.0$ Hz. Consequently, in Fig. 3(d) the area reduced to about one-third of the initial size in Fig. 3(a). Figure 3(a) suggests that the island has grown on the bare terrace, however, as can be seen in Fig. 3(k), a defect in the underlying substrate surface is observed. This defect might represent an anchoring site for the island, in agreement with the previous assumption that C$_{60}$ molecules require nucleation seeds such as substrate step edges or other surface defects for island growth at room temperature. Additionally, the island in the lower left corner, which is attached to a substrate step edge, changed in shape while scanning. Interestingly, upon reshaping, the islands tend to form straight step edges. When comparing the shape of this island in Fig.
three neighbors while more corrugated edges would result in determining the manipulation mode and unambiguously as-
can be increased until manipulation is induced. Analyzing image shrinks in size during scanning until it completely vanishes. In image molecule deposition. All following images are taken successively with a detached from the island are observed to move to nearby step 
interaction. Retracting the tip after manipulation allows for 
manipulation events could be identified here. In particular, we do not observe positive frequency shift values. Thus, despite the fact that clear tip-induced repulsive manipulation pro-
cesses exist as demonstrated in Fig. 2, the mechanism of the action strength of the NC-AFM tip with the C60 molecules gradually approaching the tip toward the surface, the inter-
creasing coordination number of the C60 molecules forming 
stable than corrugated edges, which can be explained by the 
authors are gratefully acknowledged.

3(a) with Fig. 3(k) or Fig. 3(l), the initially frayed edges become straight. This indicates that straight edges are more stable than corrugated edges, which can be explained by the increased coordination number of the C60 molecules forming the edges. For a straight edge, an edge C60 molecule has three neighbors while more corrugated edges would result in a smaller coordination number. The C60 molecules that are detached from the island are observed to move to nearby step edges or C60 islands in the vicinity. Moreover, they might be anchored to surface defects, which could explain the increase in single bright protrusions seen in this image series. We analyzed the frequency shift data taken during the manipulation process shown in Fig. 3. No significant mani-
plot the observed manipulation to repulsive tip-sample interaction. Retracting the tip after manipulation allows for reproducible imaging and evaluating the manipulation result. Besides hole formation, we also observed the movement of a domain boundary by one repeat distance. This movement is associated with the manipulation of a stacking fault and a rather large mass transport. Additionally, we observed re-
shaping and removal of islands. For the latter manipulation it is not clear so far, whether it might be induced by thermally assisted manipulation.

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G. E. Moore, Electronics 38, 114 (1965).

FIG. 3. (Color online) Series of NC-AFM images at almost the same fre-
quency shift setpoint (13.0–15.0 Hz), 62 × 62 nm², frequency shift channel, and backward scans. The first image is taken approximately 100 min after molecule deposition. All following images are taken successively with a time per frame of 9 min 20 s. The isolated island in the upper part of the image shrinks in size during scanning until it completely vanishes. In image (k) a substrate depression is observed, which is assumed to represent the nucleation seed for the island growth (see Ref. 27).